## PATENT COOPERATION TREATY

# **PCT**

### INTERNATIONAL PRELIMINARY EXAMINATION REPORT

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference 5470.316WO	FOR FURTHER ACTION		on of Transmittal of International xamination Report (Form PCT/IPEA/416)			
International application No.	International filing date (day/mo	nth/year)	Priority date (day/month/year)			
PCT/US01/31504	10 October 2001 (10.10.2001)		12 October 2000 (12.10.2000)			
International Patent Classification (IPC) or national classification and IPC						
IPC(7): G03F 7/004, 7/26, 7/36 and US Cl.: 430/270.1, 311, 313, 314, 329						
Applicant						
UNIVERSITY AT NORTH CAROLINA	A AT CHAPEL HILL					
<ol> <li>This international preliminary examination report has been prepared by this International Preliminary Examining Authority and is transmitted to the applicant according to Article 36.</li> <li>This REPORT consists of a total of sheets, including this cover sheet.</li> <li>This report is also accompanied by ANNEXES, i.e., sheets of the description, claims and/or drawings which have been amended and are the basis for this report and/or sheets containing rectifications made before this Authority (see Rule 70.16 and Section 607 of the Administrative Instructions under the PCT).</li> </ol>						
These annexes consist of a						
3. This report contains indica	ations relating to the following	items:	•			
I Basis of the repo	ort					
II Priority						
III Non-establishme	ent of report with regard to no	elty, inventive	step and industrial applicability			
IV Lack of unity of	f invention					
	nent under Article 35(2) with r tations and explanations suppor					
VI Certain docume		<b>3</b>				
	in the international application					
	••	nation				
VIII Certain observa	VIII Certain observations on the international application					
Data of malarian of the data of						
Date of submission of the demand	Date of submission of the demand  Date of completion of this report					
02 April 2002 (02.04.2002)	26 N	26 November 2002 (26.11.2002)				
Name and mailing address of the IPEA/U	•	Authorized officer				
Commissioner of Patents and Trademark Box PCT Washington, D.C. 20231		Mark Huff				
Facsimile No. (703)305-3230		hone No. 703-30	08-0661			
Form PCT/IDEA /400 (cover sheet)(July 10	orm PCT/IPEA/409 (cover sheet)(July 1998)					

#### INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.	
PCT/US01/31504	

I.	Basis of the report	
1.	With regard to the elements of the international application:*	
	the international application as originally filed.	
	the description:	
	pages 1-31 as originally filed	
	pages NONE , filed with the demand pages NONE , filed with the letter of .	
	the claims:	
	pages 32-44, as originally filed pages NONE , as amended (together with any statement) under Article 19	
	pages NONE , filed with the demand	
	pages NONE , filed with the letter of	
	the drawings	
	pages 1-2 , as originally filed	
	pages NONE , filed with the demand	
	pages NONE , filed with the letter of	
	the sequence listing part of the description:	
	pages NONE , as originally filed pages NONE , filed with the demand	
	pages NONE, filed with the letter of	
2.	With regard to the language, all the elements marked above were available or furnished to this Authority in the	
	language in which the international application was filed, unless otherwise indicated under this item.	
	These elements were available or furnished to this Authority in the following language which is:	
	the language of a translation furnished for the purposes of international search (under Rule23.1(b)).	
	the language of publication of the international application (under Rule 48.3(b)).	
	the language of the translation furnished for the purposes of international preliminary examination (under Ru 55.2 and/or 55.3).	ıles
3.	With regard to any nucleotide and/or amino acid sequence disclosed in the international application, the international preliminary examination was carried out on the basis of the sequence listing:	
	contained in the international application in printed form.	
	filed together with the international application in computer readable form.	
	furnished subsequently to this Authority in written form.	
	furnished subsequently to this Authority in computer readable form.	
	The statement that the subsequently furnished written sequence listing does not go beyond the disclosure in	the
	international application as filed has been furnished.	
	The statement that the information recorded in computer readable form is identical to the written sequence has been furnished	listing
4.	The amendments have resulted in the cancellation of:	
	the description, pages NONE	
	the claims, Nos. NONE	
	the drawings, sheets/fig NONE	
5.	This report has been established as if (some of) the amendments had not been made, since they have been considered to beyond the disclosure as filed, as indicated in the Supplemental Box (Rule 70.2(c)).**	) go
thi	Replacement sheets which have been furnished to the receiving Office in response to an invitation under Article 14 are referred is report as "originally filed" and are not annexed to this report since they do not contain amendments (Rules 70.16 and 70.17 Any replacement sheet containing such amendments must be referred to under item 1 and annexed to this report.	

## PATENT COOPERATION TREATY

From the INTERNATIONAL PRELIMINARY EXA	AMINING AUTHORITY			
To: ROBERT J. SMITH MYERS BIGEL SIBLEY & SAJOVEC P.O. BOX 37428 RALEIGH, NC 27627		PCT WRITTEN OPINION		
	·	Date of Mailing		
Applicant's or agent's file reference	· · · · · · · · · · · · · · · · · · ·	(day/month/year) REPLY DUE		
5470.316WO	•	within 2 months/days from the above date of mailing		
International application No.	International filing date (	(day/month/year)	Priority date (day/month/year)	
PCT/US01/31504	10 October 2001 (10.10.	2001)	12 October 2000 (12.10.2000)	
International Patent Classification (IPC)				
   TPC(7): G03F 7/004, 7/26, 7/36-and-US	Cl.: 430/270-1-31-1-313	314, 329		
Applicant		, 51., 525		
UNIVERSITY AT NORTH CAROLINA	A AT CHAPEL HILL			
ON VERSIT I THE WORLD CARGESTA				
1. This written opinion is the fir	rst (first, etc.) drawn by t	his International Pro	eliminary Examining Authority.	
This opinion contains indicati	ions relating to the following	na itama:		
2. This opinion contains indicati	ions relating to the following	ng items:		
I Basis of the opini	on			
II Priority				
][				
III Non-establishmen	it of opinion with regard to	novelty, inventive	step and industrial applicability	
IV Lack of unity of i	nvention			
	ent under Rule 66.2 (a)(ii) vanations supporting such st	•	ty, inventive step or industrial applicability;	
VI Certain document	s cited		•	
VII Certain defects in	the international application	on		
VIII Certain observation	ons on the international app	olication		
3. The applicant is hereby <b>invit</b>	ed to words to this oninion			
When? See the time		applicant-may, bef	ore the expiration of that time limit, request	
How? By submitting	- <del>-</del>	nied, where approp	riate, by amendments, according to Rule 66.3. es 66.8 and 66.9.	
For the exam				
If no reply is filed, the inter	national preliminary exam	ination report will b	e established on the basis of this opinion.	
4. The final date by which the international preliminary examination report must be established according to Rule 69.2 is: 12 February 2003 (12.02.2003)				
Name and mailing address of the IPEA		Authorized officer		
Commissioner of Patents and Trademar Box PCT	KS	Mark Huff		
Washington, D.C. 20231 Facsimile No. (703)305-3230		Telephone No. 703-308-0661		

#### WRITTEN OPINION

International	applica	ation	No.

PCT/US01/31504

I.	Basis of the opinion
1.	With regard to the elements of the international application:*
	the international application as originally filed the description:  pages 1-31, as originally filed pages NONE, filed with the demand pages NONE, filed with the letter of
	the claims:  pages 32-44 , as originally filed pages NONE , as amended (together with any statement) under Article 19 pages NONE , filed with the demand pages NONE , filed with the letter of
	the drawings:  pages 1-2 , as originally filed pages NONE , filed with the demand pages NONE , filed with the letter of .
	the sequence listing part of the description:  pages NONE , as originally filed pages NONE , filed with the demand pages NONE , filed with the letter of
	With regard to the language, all the elements marked above were available or furnished to this Authority in the language in which the international application was filed, unless otherwise indicated under this item.  These elements were available or furnished to this Authority in the following language which is:
	the language of a translation furnished for the purposes of international search (under Rule23.1(b)).  the language of publication of the international application (under Rule 48.3(b)).  the language of the translation furnished for the purposes of international preliminary examination(under Rules 55.2 and/or 55.3).
	With regard to any nucleotide and/or amino acid sequence disclosed in the international application, the written opinion was drawn on the basis of the sequence listing:
	contained in the international application in printed form.  filed together with the international application in computer readable form.  furnished subsequently to this Authority in written form.  furnished subsequently to this Authority in computer readable form.  The statement that the subsequently furnished written sequence listing does not go beyond the disclosure in the international application as filed has been furnished.  The statement that the information recorded in computer readable form is identical to the written sequence listing
4.	has been furnished.  The amendments have resulted in the cancellation of:
	the description, pages NONE the claims, Nos. NONE the drawings, sheets/fig NONE
5.	This opinion has been drawn as if (some of) the amendments had not been made, since they have been considered to go beyond the disclosure as filed, as indicated in the Supplemental Box (Rule 70.2(c)).
	Replacement sheets which have been furnished to the receiving Office in response to an invitation under Article 14 are referred to in sopinion as "originally filed."

International application No. PCT/US01/31504

#### WRITTEN OPINION

V. Reasoned statement under Rule 66.2(a)(ii) we citations and explanations supporting such s			inventive step	r industrial applicability;
1. STATEMENT				
Novelty (N)	Claims	1-33, 67		YES
	Claims	34-66		NO
Inventive Step (IS)	Claims	6, 7, 22, 23		YES
michine step (13)		1-5, 8-21, 24-6	57	NO
	<b>.</b> .			
Industrial Applicability (IA)	Claims Claims			YES NO
2. CITATIONS AND EXPLANATIONS Claims 33-67 lack novelty under PCT Article 33(2) as b	eing antici	pated by Allen (	(US Patent 5 <del>,66</del> 5,5	27).
Allen discloses coating on a substrate a polymeric film, polymeric film is a polymer such as fluorinated polymer (col.2, 21-46). The film is imagewise exposed to DUV image is then developed using carbon dioxide critical fluoring carbon dioxide carbon dioxide carbon dioxide carbon dioxide carbon d	s (polymet or x-ray w	hylmethacrylate vith less than abo	e) and polymers have	ving alkylsiloxy substituents
Claims 1-5, 8-21, 24-43, 46-56 and 59-67 lack an inven Patent 6,001,418).	tive step u	nder PCT Articl	le 33(3) as being ob	ovious over DeSimone (US
DeSimone discloses a spin coating method. A thin film coated by applying a carbon dioxide liquid to a surface pused to remove materials from a substrate. Resists may the mixture is comprised of carbon dioxide and a fluorop DeSimone does not disclose imagewise exposing the phoin the art to expose the photoresist to light through a mamanner.	contain ad contain ad polymer, s otoresist la	the substrate as a ditives such as p uch as a fluoroa yer. However i	a carrier. The carb photoacid generator crylate polymer (co t would have been	oon dioxide liquid may also be rs. In a preferred embodiment ol.1, 12-45, col.4, 11-40). obvious to one of ordinary skill
Claims 34-40, 44-51, 53, 57-63, 65 and 66 lack an inverted 6,045,877).	ntive step (	under PCT Artic	cle 33(3) as being o	obvious over Gleason (US Paten
Gleason discloses a pyrolytic chemical vapor deposition imagewise exposed to radiation. The exposed resist is the development process in order to photo oxidize portions of etching mask (col19, 1-col.20, 36). Gleason uses the recontaining material or an ionic material on the surface of been obvious to one of ordinary skill in the art to use the subtractive etching process, because both are convention	hen expose of the resis sist patterr f the wafer e resist pat	ed to an oxygen of the resulting in a case an etching in wherein the restern as a mask f	containing plasma of photoresist pattern nask and does not consist has been removed an additive proc	or supercritical CO2 which may be used as an disclose depositing a metal yed. However it would have
Claims 1-67 have industrial applicability as defined by P manufacturing an integrated circuit.	CT Article	e 33(4). The me	thod may be used t	to form a resist image when
NEW CITATIONS				

WR	ITTEN	OPIN	NOIL

International application No. PCT/US01/31504

#### Supplemental Box

(To be used when the space in any of the preceding boxes is not sufficient)

#### TIME LIMIT:

The time limit set for response to a Written Opinion may not be extended. 37 CFR 1.484(d). Any response received after the expiration of the time limit set in the Written Opinion will not be considered in preparing the International Preliminary Examination Report.

Form PCT/IPEA/408 (Supplemental Box) (July 1998)

#### INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No. PCT/US01/31504

V. Bassarad statement under Bule 66 2(a)(5)	vedth magai	-d to movedty inventi	vo ston on industrial analisabilitus
V. Reasoned statement under Rule 66.2(a)(ii) citations and explanations supporting such			ve step or industrial applicability;
1. STATEMENT			
Novelty (N)	Claims	1-33, 67	YE
	· Claims		NONO
Inventive Step (IS)	Claime	6, 7, 22, 23	YE
inventive step (13)		1-5, 8-21, 24-67	NO
			·
Industrial Applicability (IA)	Claims		YE.
	Claims	NONE	NO
Claims 33-67 lack novelty under PCT Article 33(2) at Allen discloses coating on a substrate a polymeric film polymeric film is a polymer such as fluorinated polym (col.2, 21-46). The film is imagewise exposed to DU image is then developed using carbon dioxide critical Claims 1-5, 8-21, 24-43, 46-56 and 59-67 lack an inv Patent 6,001,418).  DeSimone discloses a spin coating method. A thin fil coated by applying a carbon dioxide liquid to a surfact used to remove materials from a substrate. Resists in the mixture is comprised of carbon dioxide and a fluo DeSimone does not disclose imagewise exposing the pin the art to expose the photoresist to light through a manner.  Claims 34-40, 44-51, 53, 57-63, 65 and 66 lack an in 6,045,877).  Gleason discloses a pyrolytic chemical vapor deposition imagewise exposed to radiation. The exposed resist in development process in order to photo oxidize portion etching mask (col19, 1-col.20, 36). Gleason uses the containing material or an ionic material on the surface been obvious to one of ordinary skill in the art to use subtractive etching process, because both are convent.	m, a photoser ners (polymer fluid (col.4, rentive step use portion of a polymer portion of any contain according contain according to the contain	nsitive generator and acithylmethacrylate) and point less than about 1-50 29-53).  Inder PCT Article 33(3)  Interior material, such as a the substrate as a carrier diditives such as photoaciuch as a fluoroacrylate yer. However it would be photoresists are convertible of the substrate as a carrier as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a mask for an activity of the substrate as a carrier as a mask for an activity of the substrate as a carrier as a mask for an activity of the substrate as a carrier as a substrate as a carrie	d labile groups. The first component of all powers having alkylsiloxy substituents mJ/cm2 (col.4, 45-59). The negative to as being obvious over DeSimone (US photoresist or interlayer dielectric, is The carbon dioxide liquid may also be digenerators. In a preferred embodiment polymer (col.1, 12-45, col.4, 11-40), have been obvious to one of ordinary skintionally used to form a pattern in this distribution of the process of the pattern which may be used as an indices not disclose depositing a metal open removed. However it would have ditive process, instead of as a mask for a
Claims 1-67 have industrial applicability as defined by manufacturing an integrated circuit.	y PCT Articl	e 33(4). The method ma	y be used to form a resist image when
<u> </u>			
NEW CITATIONS	0		
•	-		
	•		